

Notice of References Cited

Application/Control No.

09/730,508

Applicant(s)/Patent Under
Reexamination
YAN ET AL.

Examiner

Christina Ildebrando

Art Unit

1754

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,662,869	09-1997	Abe et al.	422/171
	B	US-6,139,808	10-2000	Mizuno et al.	422/171
	C	US-6,074,973	06-2000	Lampert et al.	423/213.2
	D	US-6,047,544	04-2000	Yamamoto et al.	422/171
	E	US-US 2002/0057997	05-2002	Mizuno et al.	422/171
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 904 827	03-1999	EPO	Noda et al.	-----
	O	EP 0 749 774	12-1996	EPO	Noda et	-----
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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